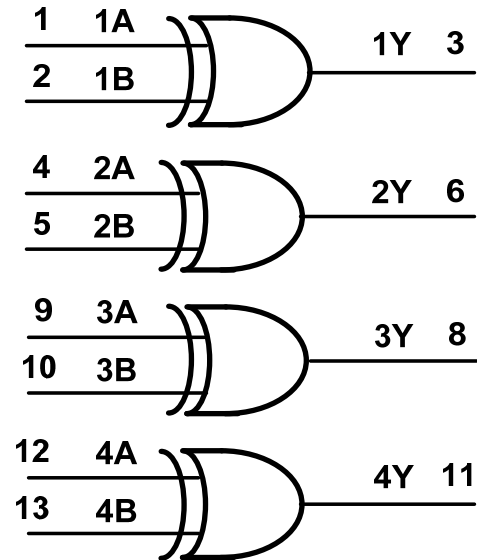


Pin Descriptions

Pin Number	Pin Name	Description
1	1A	Data Input
2	1B	Data Input
3	1Y	Data Output
4	2A	Data Input
5	2B	Data Input
6	2Y	Data Output
7	GND	Ground
8	3Y	Data Output
9	3A	Data Input
10	3B	Data Input
11	4Y	Data Output
12	4A	Data Input
13	4B	Data Input
14	Vcc	Supply Voltage

Logic Diagram



Function Table

Inputs		Output
A	B	Y
L	L	L
L	H	H
H	L	H
H	H	L

Absolute Maximum Ratings (Note 4)

Symbol	Description	Rating	Unit
ESD HBM	Human Body Model ESD Protection	2	kV
ESD CDM	Charged Device Model ESD Protection	1	kV
ESD MM	Machine Model ESD Protection	200	V
V _{CC}	Supply Voltage Range	-0.5 to 7.0	V
V _I	Input Voltage Range note 4	-0.5 to 7.0	V
I _{IK}	Input Clamp Current V _I < 0V	-20	mA
I _{OK}	Output Clamp Current V _O < -0V	-50	mA
I _O	Continuous Output Current - 0.5V < V _O < V _{CC} + 0.5V	+/- 25	mA
I _{CC}	Continuous Current Through Vcc	50	mA
I _{GND}	Continuous Current Through GND	-50	mA
T _J	Operating Junction Temperature	-40 to 150	°C
T _{STG}	Storage Temperature	-65 to 150	°C
P _{TOT}	Total Power Dissipation	500	mW

Note: 4. Stresses beyond the absolute maximum may result in immediate failure or reduced reliability. These are stress values and device operation should be within recommend values.

Recommended Operating Conditions (Note 5)

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	Supply Voltage	–	2.0	5.5	V
V _I	Input Voltage	–	0	5.5	V
V _O	Output Voltage	–	0	V _{CC}	V
I _{OH}	High-Level Output Current	2.0V	–	-50	mA
		2.3V to 2.7V	–	-2	μA
		3.0V to 3.6V	–	-6	mA
		4.5V to 5.5V	–	-12	mA
I _{OL}	Low-Level Output Current	2.0V	–	50	μA
		2.3V to 2.7V	–	2	mA
		3.0V to 3.6V	–	6	mA
		4.5V to 5.5V	–	12	mA
Δt/ΔV	Input Transition Rise or Fall Rate	2.3V to 2.7V	–	200	ns/V
		3.0V to 3.6V	–	100	
		4.5V to 5.5V	–	20	
T _A	Operating Free-Air Temperature	–	-40	+125	°C

Note: 5. Unused inputs should be held at V_{CC} or Ground.

Electrical Characteristics

Symbol	Parameter	Test Conditions	V _{cc}	T _A = -40 to +85°C		T _A = -40 to +125°C		Unit
				Min	Max	Min	Max	
V _{IH}	High-Level Input Voltage	–	2.0V	1.5	–	1.5	–	V
		–	2.3V to 2.7V	V _{CC} X 0.7	–	V _{CC} X 0.7	–	
		–	3.0V to 3.6V	V _{CC} X 0.7	–	V _{CC} X 0.7	–	
		–	4.5V to 5.5V	V _{CC} X 0.7	–	V _{CC} X 0.7	–	–
V _{IL}	Low-Level Input Voltage	–	2.0V	–	0.5	–	0.5	V
		–	2.3V to 2.7V	–	V _{CC} X 0.3	–	V _{CC} X 0.3	
		–	3.0V to 3.6V	–	V _{CC} X 0.3	–	V _{CC} X 0.3	
		–	4.5V to 5.5V	–	V _{CC} X 0.3	–	V _{CC} X 0.3	–
V _{OH}	High-Level Output Voltage	I _{OH} = -50μA	2.0V to 5.5V	V _{CC} -0.1	–	V _{CC} -0.1	–	V
		I _{OH} = -2mA	2.3V	2.0	–	2.0	–	
		I _{OH} = -6mA	3.0V	2.48	–	2.48	–	
		I _{OH} = -12mA	4.5V	3.8	–	3.8	–	
V _{OL}	Low-Level Output Voltage	I _{OL} = 50μA	2.0V to 5.5V	–	0.1	–	0.1	V
		I _{OL} = 2mA	2.3V	–	0.4	–	0.4	
		I _{OL} = 6mA	3.0V	–	0.44	–	0.44	
		I _{OL} = 12mA	4.5V	–	0.55	–	0.55	
I _{OFF}	Power Down Leakage Current	V _I or V _O = 0 to 5.5V	0V	–	5	–	5	μA
I _I	Input Current	V _I = GND or 5.5V	0 to 5.5V	–	±1	–	±1	μA
I _{CC}	Supply Current	V _I = GND or V _{CC} I _O = 0	5.5V	–	20	–	20	μA

Switching Characteristics

Symbol	Parameter	Test Conditions	V _{CC}	T _A = +25°C			-40 to +85°C		-40 to +125°C		Unit
				Min	Typ.	Max	Min	Max	Min	Max	
t _{PD}	Propagation Delay A _N to Y _N	Figure 1 C _L = 15pF	2.5V ± 0.2V	-	7.9	17.6	1	21	1	22	ns
			3.3V ± 0.3V	-	5.5	11	1	13	1	14	
			5.0V ± 0.5V	-	3.7	6.8	1	8	1	9	
		Figure 1 C _L = 50 pF	2.5V ± 0.2V	-	10.5	22.6	1	26.5	1	27.5	ns
			3.3V ± 0.3V	-	7.4	14.5	1	16.5	1	17.5	
			5.0V ± 0.5V	-	5.3	8.8	1	10	1	11	

Operating Characteristics

T_A = +25°C

Parameter		Test Conditions	V _{CC}	TYP	Unit
C _{pd}	Power Dissipation Capacitance per Gate	F = 10MHz C _L = 50pF	3.3V	8.4	pF
			5.0V	8.8	

Noise Characteristics

V_{CC} = 3V, C_L = 50pF T_A = +25°C

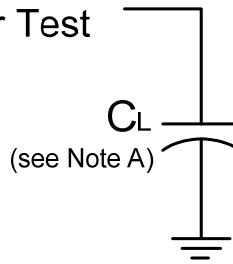
Symbol	Parameter	Min	Typ.	Max	Unit
V _{OL(p)}	Quiet output, maximum dynamic V _{OL}	-	0.2	0.8	V
V _{OL(V)}	Quiet output, minimum dynamic V _{OL}	-	-0.1	-0.8	V
V _{OH(V)}	Quiet output, minimum dynamic V _{OH}	-	3.1	-	V
V _{IH(D)}	High Level dynamic input voltage	2.31	-	-	V
V _{IL(D)}	Low Level dynamic input voltage	-	-	0.99	V

Package Characteristics

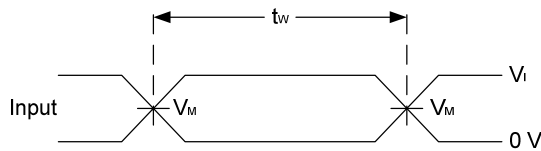
Symbol	Parameter	Test Conditions	V _{CC}	Min	Typ.	Max	Unit
C _i	Input Capacitance	V _i = V _{CC} – or GND	2.0 to 5.5V	-	3.3	10	pF

Parameter Measurement Information

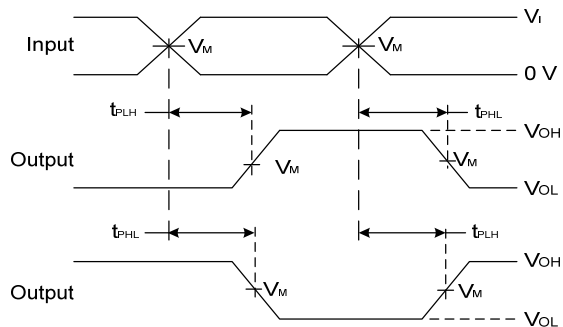
From Output
Under Test



V _{CC}	Inputs		V _M	C _L
	V _I	t _r /t _f		
2.0V to 5.5V	V _{CC}	<3ns	V _{CC} /2	15pF or 50pF



**Voltage Waveform
Pulse Duration**

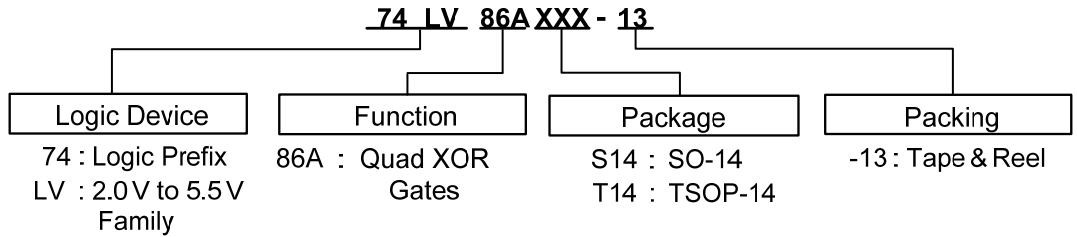


**Voltage Waveform
Propagation Delay Times
Inverting and Non Inverting Outputs**

- Notes:
- A . Includes test lead and test apparatus capacitance.
 - B. All pulses are supplied at pulse repetition rate ≤ 10MHz
 - C. Inputs are measured separately one transition per measurement
 - D. t_{PLH} and t_{PHL} are the same as t_{PD}

Figure 1. Load Circuit and Voltage Waveforms

Ordering Information

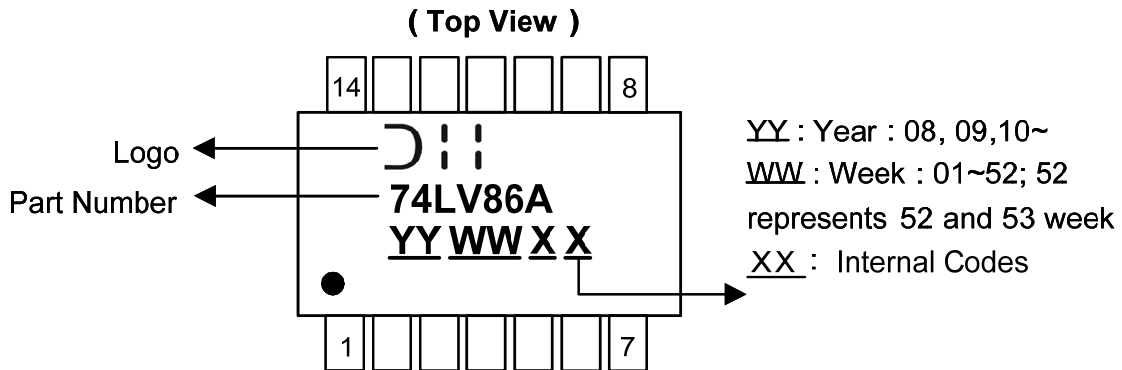


Device	Package Code	Packaging (Note 6)	13" Tape and Reel	
			Quantity	Part Number Suffix
74LV86AS14-13	S14	SO-14	2500/Tape & Reel	-13
74LV86AT14-13	T14	TSSOP-14	2500/Tape & Reel	-13

Note: 6. The taping orientation and tape details can be found at <http://www.diodes.com/datasheets/ap02007.pdf>

Marking Information

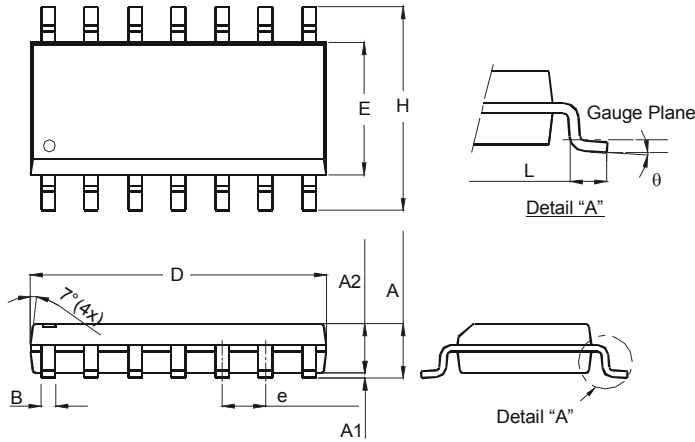
(1) SO14, TSSOP14



Part Number	Package
74LV86AS14	SO-14
74LV86AT14	TSSOP-14

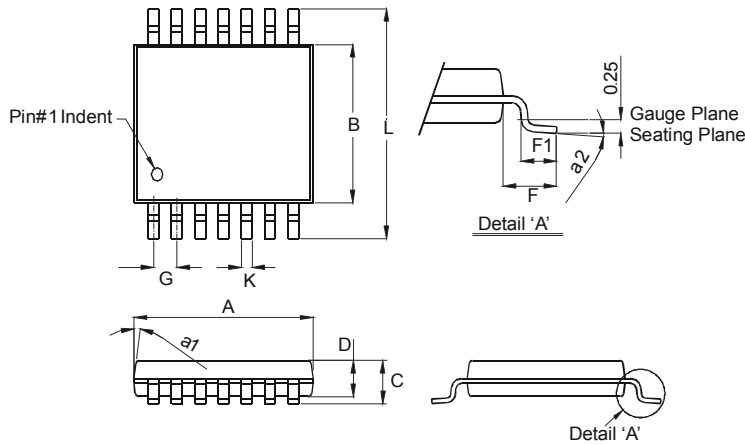
Package Outline Dimensions (All Dimensions in mm)

Package Type: SO-14



SO-14		
Dim	Min	Max
A	1.47	1.73
A1	0.10	0.25
A2	1.45 Typ	
B	0.33	0.51
D	8.53	8.74
E	3.80	3.99
e	1.27 Typ	
H	5.80	6.20
L	0.38	1.27
θ	0°	8°
All Dimensions in mm		

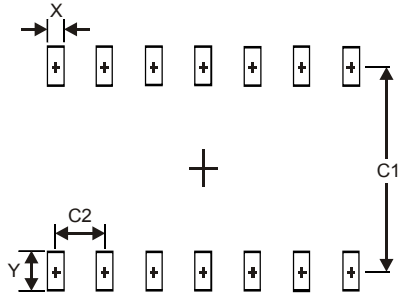
Package Type: TSSOP-14



TSSOP-14		
Dim	Min	Max
a1	7° (4X)	
a2	0°	8°
A	4.9	5.10
B	4.30	4.50
C	—	1.2
D	0.8	1.05
F	1.00 Typ	
F1	0.45	0.75
G	0.65 Typ	
K	0.19	0.30
L	6.40 Typ	
All Dimensions in mm		

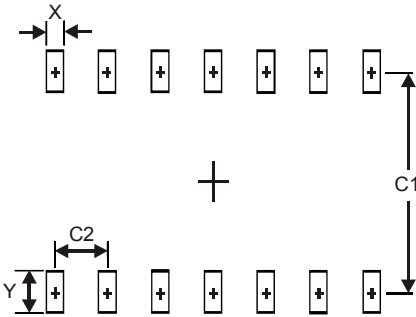
Suggested Pad Layout

Package Type: SO-14



Dimensions	Value (in mm)
X	0.60
Y	1.50
C1	5.4
C2	1.27

Package Type: TSSOP-14



Dimensions	Value (in mm)
X	0.45
Y	1.45
C1	5.9
C2	0.65

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